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# A novel design for a small retractable cylindrical mirror analyzer

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## SHOP NOTES

*These are "how to do it" papers. They should be written and illustrated so that the reader may easily follow whatever instruction or advice is being given.*

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### A novel design for a small retractable cylindrical mirror analyzer

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In this paper we will review the performance of a "miniature" single pass cylindrical mirror analyzer (CMA) which we have used successfully in a variety of experiments. The underlying premise behind this CMA design was to minimize spatial requirements while maintaining an acceptable level of instrumental resolution. While we are presenting the results of a single pass cylindrical mirror analyzer, improvements on the present design, such as going to a double pass design, will undoubtedly improve the instrumental resolution. © 1995 American Vacuum Society.

The electro-optics of the CMA is a modification from a standard design by Lee and Pethica<sup>1</sup> derived from standard electrostatic relationships,<sup>2-5</sup> where the only design restriction is that the inner cylinder is held at ground. The CMA is designed around an optimal acceptance angle ( $\theta_0$ ) of  $42^\circ 18.5'$ ,<sup>6</sup> with the focus approximately 6 mm in front of the entrance slit of the inner cylinder. The overall dimensions of the electro-optics are approximately 30 mm in diameter and 45 mm in length. The outer shell of the CMA is constructed of Mu metal to minimize resolution broadening due to stray magnetic fields. A simple commercial channeltron is employed for electron detection. In Fig. 1 a basic schematic of the CMA design is shown. The control scheme of the CMA illustrated in Fig. 2 is only one of many ways that the control electronics can be configured.

In Fig. 3 we present the differentiated spectrum of the elastic peak of electrons reflected off of the (100) surface of a flat nickel single crystal. The sample area was approximately  $12 \text{ mm}^2$  (approximately the size of the electron beam) and the sample current during data acquisition was  $10 \mu\text{A}$ . From this spectrum we see that the instrumental linewidth of the elastic peak is quite good and that the instrumental energy resolution ( $R = \Delta E/E_0$ ) of the analyzer is 1.5%. An instrumental asymmetry in the signal is introduced by the analyzer as a consequence of inhomogeneities in the fields near the exit aperture and due to the elimination of conducting mesh over the entrance and exit slits in an effort to increase electron transmission. This asymmetry is most apparent in the derivative of the elastic peak in Fig. 3.

The CMA has been constructed to fit onto a linear motion feedthrough mounted on a 2.75 in. conflat flange. The advantages of this design are simple, but highly attractive. The placement of the CMA on a linear motion feedthrough eliminates restraints on chamber designs that are otherwise imposed by the focusing requirements of conventional fixed

CMA detectors. This has the added advantage that it reduces overcrowding, which often occurs in many experimental systems. By mounting the CMA onto a 2.75 in. flange, the analyzer can easily be moved to different locations within a typical ultrahigh vacuum (UHV) chamber. For Auger electron spectroscopy off of a crystal surface, the analyzer was controlled as shown schematically in Fig. 2.

In addition to successfully acquiring Auger spectra from single crystals, we have also obtained Auger electron spectra of atomic Ar beams in a cross beam experiment. It is from this experiment that the true versatility of the CMA design becomes most evident. The experiment consisted of crossing tunable ionizing light from a synchrotron light source with an Ar beam. The photon energy is scanned across an energy range where Ar Auger electron yields are expected, while the CMA is held at a constant pass energy, which in this case corresponded to the kinetic energy of the Ar *LMM* Auger process. The specifics of the experiment are discussed in greater detail elsewhere.<sup>7</sup> We have also used this CMA in constant final state spectroscopy and characteristic energy loss spectroscopy experiments.

In Fig. 4 we present Auger spectra of the atomic Ar *LMM* Auger process acquired at three different photon energies. The broad feature centered at a kinetic energy of approximately 210 eV in the three spectra corresponds to the Ar Auger electrons, while the feature at approximately 120 and 150 eV in the spectra acquired at photon energies of 370 and 400 eV, respectively, originate from Ar *2p* core electron excitations. The limitations of the CMA in this acquisition mode are apparent from the poor resolution of the Auger spectra in Fig. 4. In reality, the broad Auger feature is composed of numerous individual Auger processes which are not resolvable in our spectra, but have been resolved by Akela *et al.*<sup>8</sup> using a larger diameter CMA.

We have attributed the poor resolution of the spectra in

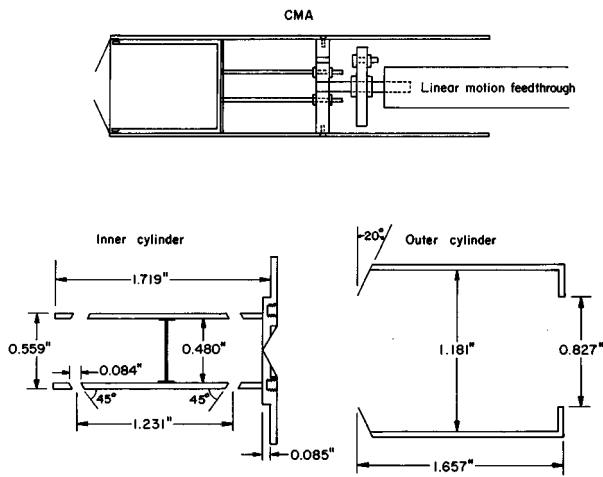


FIG. 1. A schematic drawing of the cylindrical mirror analyzer. The illustration at the top of the figure is an overview of the construction of the analyzer and the two illustrations at the bottom are of the inner and outer cylinders of the analyzer.

Fig. 4 to sample volume effects. In the case where the signal originates from the surface of a solid, the sampling volume is no more than a few angstroms below the surface. Therefore, the focus of the CMA, relative to the sample surface, is well defined. This is not the case for the atomic beam experiments. The sampling volume is the volume of the region where the atomic beam and the light source cross, which in

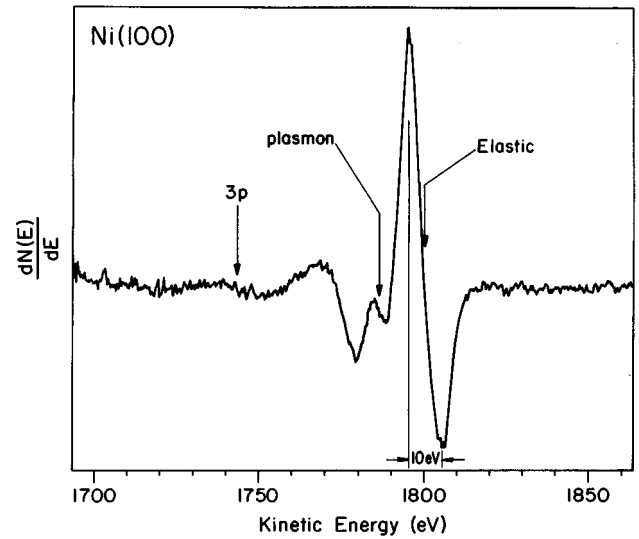


FIG. 3. A spectrum of the elastic peak of electrons reflected off of the (100) surface of a nickel single crystal. An instrumental energy resolution ( $R = \Delta E/E_0$ ) for the CMA of 1.5% has been established from the width of the elastic peak. The sample area was approximately 12 mm<sup>2</sup> (effectively the size of the electron beam) and the sample current during data acquisition was 10  $\mu$ A. The spectrum acquisition time was approximately 2 min.

this experiment was approximately 30 mm<sup>3</sup>. As a consequence, the focal point of the CMA, relative to the sampling volume, is no longer well defined, i.e., a point source approximation is no longer valid. This has the effect of broad-

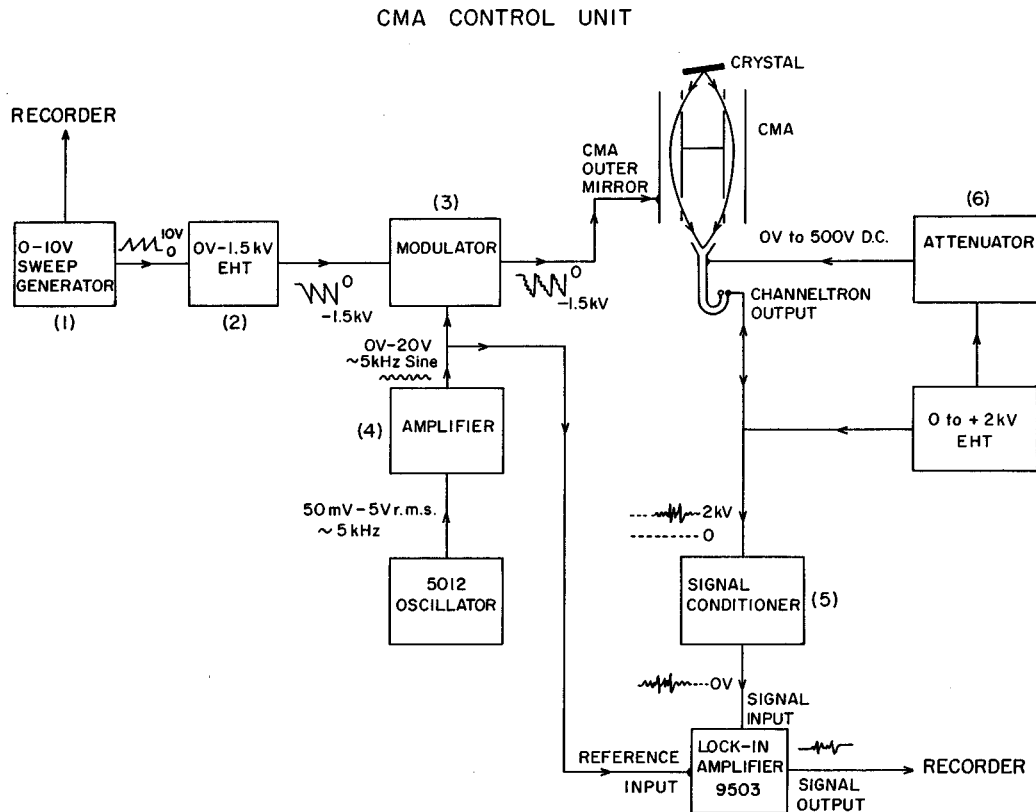


FIG. 2. A flow chart of the control electronics when the analyzer is operated in a lock-in mode, for example, when acquiring Auger spectra.

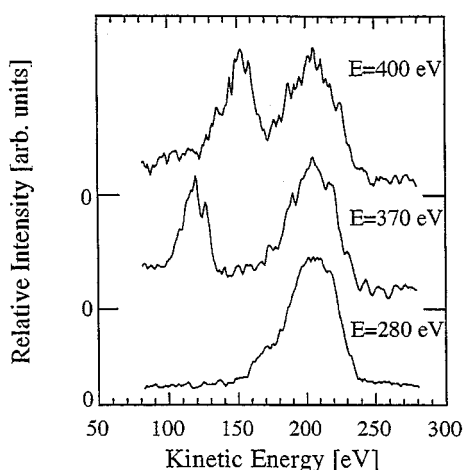


FIG. 4. Auger electron spectra of the atomic Ar *LMM* process acquired at photon energies of 280, 370, and 400 eV. The photon energy independent feature is the *LMM* Auger process, while the lower kinetic energy feature, which appears in the spectra acquired at photon energies of 370 and 400 eV, is the Ar  $2p$  excitation. The sampling volume (the volume where the synchrotron light beam and the argon cluster beam crossed) is estimated to be approximately  $30 \text{ mm}^3$ .

ening spectral features which degrades the instrumental resolution of the CMA.

In conclusion, we have designed and built a small cylindrical mirror analyzer which has demonstrated good energy resolution and versatility. By mounting the CMA on a 2.75 in. conflat flange, in conjunction with a linear motion

feedthrough, we have been able to utilize it in a variety of configurations and applications. From the elastic peak of an electron beam reflected off of a single crystal of nickel, we have determined the resolution ( $R = \Delta E/E_0$ ) of the CMA to be 1.5%. From atom cross beam experiments, we have found that the energy resolution is drastically reduced relative to Auger spectra obtained from the surfaces of single crystals. We have attributed this to the larger sampling volume of cross beam experiments, i.e., the focus of the sample is not well defined. In contrast, by running the analyzer in a constant energy mode, very good *LMM* Auger electron yield measurements of Ar clusters have been achieved.<sup>7</sup> While we have not explored the full range of applications for this design, these experiments have demonstrated the versatility and usefulness of this CMA design.

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